

CERTIFICATE OF ANALYSIS

74X WS (batch A)

Certified Reference Material Information

Type: TIN-BASE LEAD-FREE SOLDER (CAST)
Form and Size: Disc 40mm Diameter x 15mm Thickness
Manufactured by: Universal Scientific Laboratory Pty Ltd
Certified and Supplied by: MBH Analytical Ltd

Certified Analysis

Percentage element by weight

Element	Cu	Ag	Pb	Sb	Bi	Zn	Ni
Value ¹	4.58	0.298	0.037	1.49	0.0063	0.0009	0.0048
Uncertainty ²	0.05	0.007	0.003	0.04	0.0010	0.0001	0.0005

Element	Fe	As	Cd	Au	Al	In	P
Value ¹	(0.0036)	0.0105	0.00140	(0.0002)	(0.0007)	0.0032	0.0122
Uncertainty ²	-	0.0007	0.00011	-	-	0.0004	0.0009

Note: values given in parentheses are not certified - they are provided for information only

Definitions

- ¹ The certified values are the present best estimates of the true content for each element. Each value is a panel consensus, based on the averaged results of an interlaboratory testing programme, detailed on page 3.
- ² The uncertainty values are generated from the 95% confidence interval derived from the wet analysis results, in combination with a statistical assessment of the homogeneity data, as described on page 2.

Certified by:

on 6th December 2005

MBH ANALYTICAL LIMITED _____

C Eveleigh

Method of Preparation

This reference material was produced from commercial tin/silver/copper alloy; the traces were added as single elements or as master alloys. The melt was cast by sequential transfer of aliquots into iron moulds. 2mm has been removed from the working face to minimise any surface effects.

Sampling

Samples for chemical analysis were taken from various positions throughout the casting process. At least 10% of all discs were selected for non-destructive homogeneity testing.

Homogeneity

The discs were checked for sample and batch uniformity using an optical emission spectrometer. One additional disc was checked for vertical uniformity using the same method.

Using the meaned data from each surface, standard deviation values were derived for each element as an indicator of any non-homogeneity (as determined for the specific sample size taken by the spectrometer).

The vertical uniformity check showed that this material is of satisfactory homogeneity only for the first 10 mm of depth from the original chilled face.

Chemical Analysis

Analysis was carried out on turnings taken from samples representative of the product. It was performed by participating laboratories mostly operating within the terms of EN ISO/IEC 17025 - 2000, using documented standard methods of analysis.

The individual values listed overpage are the average of each analyst's results.

Estimation of Uncertainties

Each element certified has been analysed by several laboratories, and 95% half-width confidence intervals ($C_{(95\%)}$) for the resultant mean values have been derived by the method shown on page 3.

As a separate exercise, the degree of non-homogeneity of the batch for each element has been quantified by a programme of non-destructive application testing, discussed above.

The final certified uncertainty for each element has been derived by combining these two factors, using the square-root of the summed squares.

Traceability

Most of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to a national authority. It is part of the requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised primary reference materials.

Usage

Intended use: With optical emission and X-ray fluorescence spectrometers.

Recommended method of use: Tin is generally prepared by machining on a lathe. However, users are recommended to follow the calibration and sample preparation procedures specified by the relevant instrument manufacturer.

Preparation should be the same for reference materials and the samples for test.

A minimum of five consistent replicate analyses is recommended to provide the necessary sample size. Users are advised to check against possible bias between reference materials and production samples due to differences in metallurgical history, and be aware of possible inter-element effects.

Analytical Data

Percentage element by weight

Sample	Cu	Ag	Pb	Sb	Bi	Zn	Ni
1	4.509	0.287	0.0308	1.410	0.0045	0.0007	0.0033
2	4.526	0.292	0.0310	1.424	0.0050	0.0008	0.0040
3	4.530	0.293	0.0325	1.450	0.0050	0.0008	0.0044
4	4.534	0.294	0.0360	1.468	0.0053	0.0009	0.0045
5	4.548	0.296	0.0368	1.496	0.0053	0.0009	0.0049
6	4.562	0.296	0.0373	1.512	0.0064	0.0011	0.0050
7	4.572	0.307	0.0373	1.522	0.0069	0.0011	0.0050
8	4.601	0.308	0.0376	1.528	0.0076	0.0012	0.0054
9	4.620	0.310	0.0392	1.533	0.0080		0.0054
10	4.657		0.0397	1.563	0.0087		0.0059
11	4.670		0.0407				
12			0.0426				
Mean	4.575	0.298	0.0368	1.491	0.0063	0.0009	0.0048
Std Dev	0.055	0.008	0.0037	0.051	0.0015	0.0002	0.0008
C_(95%)	0.037	0.006	0.0024	0.036	0.0010	0.0001	0.0005

Sample	Fe	As	Cd	Au	Al	In	P
1	0.0026	0.0093	0.0012	0.0001	0.0002	0.0026	0.0100
2	0.0028	0.0098	0.0012	0.0001	0.0003	0.0028	0.0116
3	0.0029	0.0098	0.0012	0.0003	0.0005	0.0028	0.0120
4	0.0030	0.0100	0.0013	0.0003	0.0011	0.0028	0.0125
5	0.0033	0.0110	0.00135	0.0003	0.0012	0.0032	0.0126
6	0.0035	0.0110	0.00139	0.0003		0.0032	0.0126
7	0.0037	0.0111	0.0015			0.0032	0.0126
8	0.0042	0.0118	0.0015			0.0033	0.0135
9	0.0048		0.00153			0.0039	
10	0.0051		0.0016			0.0043	
11			0.0016				
Mean	0.0036	0.0105	0.00140	(0.0002)	(0.0007)	0.0032	0.0122
Std Dev	0.0009	0.0009	0.00016	-	-	0.0005	0.0010
C_(95%)	0.0006	0.0007	0.00011	-	-	0.0004	0.0009

Note: C_(95%) is the 95% half-width confidence interval derived from the equation:

$$C_{(95\%)} = (t \times SD) / \sqrt{n}$$

where n is the number of available values, t is the Student's t value for n-1 degrees of freedom, and SD is the standard deviation of the test results.

Participating Laboratories

Sheffield Assay Office	Sheffield, England	UKAS accreditation 0012
Laboratory Testing Inc	Hatfield, PA, USA	A2LA accreditation 0117
Universal Scientific Laboratory Pty Ltd	Milperra, NSW, Australia	NATA accreditation 0492
Institute of Iron & Steel Technology	Shanghai, China	CNAL accreditation 0783
Luo Yang Copper	Luo Yang, He Nan, China	CNAL accreditation 0173
RWTUV Laboratory	Brno, Czech Republic	CAI accreditation 1060
Sargam Metals Pvt Ltd	Chennai, India	NABL accreditation 0025
Spectroscopic Solutions Ltd	Johannesburg, South Africa	
Genitest Inc	Montreal, Canada	
Coleshill Laboratories Ltd	Coleshill, England	
Cookson Electronics, Alpha-Fry Technologies	Altoona, PA, USA	
SiPi Metals Corp	Chicago, IL, USA	

Note: to achieve National Accreditation (eg UKAS, NATA, A2LA, CNAL, CAI, NABL), test houses must demonstrate conformity to the general requirements of EN ISO/IEC 17025.

Analytical Methods Used

ELEMENT	RESULT No. & METHOD			
	ICP-AES	FAAS		OTHER
Copper	1, 2, 6, 10, 11	4, 7	3, 5, 8 9	volumetric (thiosulfate) electrogravimetric
Silver	3, 4, 6, 8, 9	2, 7	5 1	volumetric (thiocyanate) gravimetric (cupellation)
Lead	1-4, 7, 8, 10, 11	5, 6, 9, 12		
Antimony	1, 3, 5, 6, 8, 9	4, 7	2, 10	volumetric (bromate)
Bismuth	1, 2, 5, 8-10	3, 4, 6	7	photometric (iodide)
Zinc	2, 3, 5, 7, 8	1, 4, 6		
Nickel	1-4, 9, 10	5, 6, 7, 8		
Iron	1, 2, 4-6, 8, 10	3, 7	9	photometric (orthophenanthroline)
Arsenic	1, 3-8	-	2	photometric (turbidity)
Cadmium	1-3, 5-7, 9	4, 8, 10		
Gold	1-6	-		
Aluminium	1-3, 5	-	4	photometric (chrome azurol S)
Indium	1-7, 10	8, 9		
Phosphorus	1-4, 6-8	-	5	photometric (molybdenum blue)

Notes

This Certified Reference Material has been produced and certified in accordance with the requirements of ISO Guide 34-2000, ISO Guide 31-2000 and ISO Guide 35-1989, taking into account the requirements of ASTM E1724, ASTM E1831 and the ISO Guide to the Expression of Uncertainty in Measurement (GUM).

The unidirectional solidification effects associated with semi-chill casting have led to segregation and inhomogeneity in the rear portion of the disc. The above certification is therefore only applicable from the front face of the disc to a depth of 10mm. Material to the rear of the disc, to a depth of ~5mm, is not certified.

This material is liable to superficial corrosion, and there is some possibility of microstructural changes due to recrystallisation; however, it will otherwise remain stable provided adequate precautions are taken to protect it from cross-contamination, extremes of temperature and atmospheric moisture. All production records will be retained for a period of 20 years from the date of analysis. This certification will therefore expire in December 2025, although we reserve the right to make changes as issue revisions, in the intervening period.

This sample is also available in the form of chippings.

The manufacture, analysis and certification of this product were supervised by C Eveleigh, PhD, Technical Director, MBH Analytical Ltd.

The material to which this certificate of analysis refers is supplied subject to our general conditions of sale.